


<b>Search Notes</b>  	<b>Application/Control No.</b>  10760610	<b>Applicant(s)/Patent Under Reexamination</b>  SMITH, MARK JEFFREY
	<b>Examiner</b>  Nguyen, Toan D	<b>Art Unit</b>  2616

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (US-PGPUB;USPAT;EPO;IBM_TDB)	5/9/08	TN

INTERFERENCE SEARCH			
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